

<b>Notice of References Cited</b>	Application/Control No. 09/991,961	Applicant(s)/Patent Under Reexamination YANG, TAI-HER	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,801,187	04-1974	McMichael, Cyrus	359/503
	B	US-3,895,856	07-1975	Bickel, Quentin D.	40/561
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

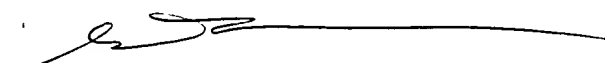
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 06274112 A	09-1994	Japan	KOBAYASHI, TAKEHARU	G09F 13/00
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,297,000	10-1981	Fries, James E.	362/557
	B	US-4,201,197	05-1980	Disner, Raymond H.	126/600
	C	US-5,479,276	12-1995	Herbermann, Carl R.	349/5
	D	US-3,780,722	12-1973	Swet, Charles J.	126/680
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 04020990 A	01-1992	Japan	FUJIWARA et al.	G09F 13/20
	O	JP 08253916 A	10-1996	Japan	MIYAMOTO et al.	E01F 09/00
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,236,792	05-2001	Fung, Chun Chung	385/115
	B	US-6,195,016	02-2001	Shankle et al.	340/815.42
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	N					
	O					
	P					
	Q					
	R					
	S					
	T					

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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